

<b>Notice of References Cited</b>	Application/Control No. 10/606,966	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,508,242	04-1996	Baumard et al.	501/152
	B	US-5,625,587	04-1997	Peng et al.	365/145
	C	US-6,231,991	05-2001	Maloney, Michael J.	428/469
	D	US-6,245,451	06-2001	Kamisawa et al.	428/697
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-326860	11-2002	Japan	Tajima et al	-/-
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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